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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
10/047,610	01/16/2002	Carl P. Babcock	039153-0325	5742
759	90 08/04/2003			
Steven C. Becker Foley & Lardner, Firstar Center 777 East Wisconsin Avenue			EXAMINER	
			ROSASCO, STEPHEN D	
Milwaukee, WI 53202-5367			ART UNIT	PAPER NUMBER
			1756	
			DATE MAILED: 08/04/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

			<i>W</i>				
Office Action Summary		Application No.	Applicant(s)				
		10/047,610	BABCOCK ET AL.				
		Examiner	Art Unit				
		Stephen Rosasco	1756				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
THE I - Exter after - If the - If NO - Failu - Any r earne	ORTENED STATUTORY PERIOD FOR REPLY MAILING DATE OF THIS COMMUNICATION. sions of time may be available under the provisions of 37 CFR 1.1: SIX (6) MONTHS from the mailing date of this communication. period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period were to reply within the set or extended period for reply will, by statute eply received by the Office later than three months after the mailing d patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be ti y within the statutory minimum of thirty (30) da vill apply and will expire SIX (6) MONTHS fron , cause the application to become ABANDON	mely filed ys will be considered timely. n the mailing date of this communication. ED (35 U.S.C. § 133).				
Status	Paragraphy (a) State (a)	4					
1)⊠	Responsive to communication(s) filed on 16						
2a)□	,—	is action is non-final.					
3) Since this application is in condition for allowance except for formal matters, prosecution as to the ments is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.  Disposition of Claims							
· _	Claim(s) 122 is/are pending in the application.						
4a) Of the above claim(s) is/are withdrawn from consideration.							
5) ☐ Claim(s) is/are allowed.							
6)⊠ Claim(s) <u>1-22</u> is/are rejected.							
7) Claim(s) is/are objected to.							
	Claim(s) are subject to restriction and/o	r election requirement.					
· ·	on Papers	,					
9) The specification is objected to by the Examiner.							
10)⊠ The drawing(s) filed on <u>16 January 2002</u> is/are: a)⊠ accepted or b)⊡ objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
11)☐ The proposed drawing correction filed on is: a)☐ approved b)☐ disapproved by the Examiner.							
If approved, corrected drawings are required in reply to this Office action.							
12)☐ The oath or declaration is objected to by the Examiner.							
Priority under 35 U.S.C. §§ 119 and 120							
13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).							
a) All b) Some * c) None of:							
1. Certified copies of the priority documents have been received.							
	2. Certified copies of the priority documents have been received in Application No						
<ul> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>							
14)☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).							
a) ☐ The translation of the foreign language provisional application has been received.  15)☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.							
Attachment(s)							
2) Notic	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) nation Disclosure Statement(s) (PTO-1449) Paper No(s) <u>2</u>	5) Notice of Informal	ry (PTO-413) Paper No(s) Patent Application (PTO-152)				
J.S. Patent and Tr	ademark Office						

Application/Control Number: 10/047,610

Art Unit: 1756

## **Detailed Action**

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-14 are rejected under 35 U.S.C. 102(b) as being anticipated by Tanaka et al. (5,549,995).

Claims 1-8, phase shifting mask comprising a transparent material having a plurality of first and second trenches which are a different depth.

Claims 9-14, wherein the trenches are produced by etching the substrate.

Tanaka et al. teach a method of manufacturing a transmitting photomask, includes a step of forming a plurality of transmitting portions including recesses having different depths alternately by etching the transparent substrate through the opening patterns by use of anisotropic etching.

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1- are rejected under 35 U.S.C. 103(a) as being unpatentable over Pierrat et al. (6,068,951) or Ito et al. (5,700,605) in view of Tanaka et al. (5,549,995).

Application/Control Number: 10/047,610

Art Unit: 1756

The claimed invention is directed to:

Claims 1-8, phase shifting mask comprising a transparent material having a plurality of first and second trenches which are a different depth.

Claims 9-14, wherein the trenches are produced by etching the substrate.

Claims 15-22, a method of testing the effect of lights having different wavelengths on a photoresist by transmitting light having a first wavelength through the first trenches and transmitting light having a second wavelength through the second trenches.

Pierrat et al. teach a phase shifting mask formed from a quartz substrate including a phase shifting layer etched into a surface of said substrate for shifting a first exposure light having a first wavelength about 180 degrees and shifting a second exposure light having a second wavelength about 180 degrees.

Ito et al. teach in a method for production of a mask for light exposure provided with a light transparent substrate and a mask pattern formed on the light transparent substrate, said mask pattern comprising a light screening pattern composed of a material which screens the exposure light and transmits the light having the longer wavelength than that of the exposure light and a phase shift pattern formed by engraving a part of the light transparent substrate, said process comprising calculating an etched depth of the light transparent substrate by determining the optical image of the light passing through the light screening pattern and the light passing through an opening of the light screening pattern or determining the phase difference between said two kinds of lights using the phase measuring light having the longer wavelength than that of the exposure light.

The teachings of Pierrat et al. or Ito et al. differ from those of the applicant in that the applicant teaches having a plurality of first and second trenches formed in the substrate, which are a different depth.

Tanaka et al. teach a method of manufacturing a transmitting photomask, includes a step of forming a plurality of transmitting portions including recesses having different depths alternately by etching the transparent substrate through the opening patterns by use of anisotropic etching.

It would have been obvious to one having ordinary skill in the art to take the teachings of Pierrat et al. or Ito et al. and combine them with the teachings of Tanaka et al. in order to make the claimed invention because it is well known in the phase shifting mask art that the depth of trench can be adjusted to transmit light that is shifted by a desired amount.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to S. Rosasco whose telephone number is (703) 308-4402.

Any inquiry of a general nature or relating to the status of this application should be directed to the Group receptionist whose telephone number is (703) 308-0661. Fax (703) 872-9310 Before Finals, 872-9311 After Finals.

S. Rosasco Primary Examiner Art Unit 1756

S.Rosasco 7/30/03